## Features

- Permanent and reversible software write protection for the first-half of the array
  - Software procedure to verify write protect status
- Hardware write protection for the entire array
- Low-voltage and standard-voltage operation
  - 1.7 ($V_{CC}$ = 1.7V to 5.5V)
- Internally organized 256 x 8
- Two-wire serial interface
- Schmitt trigger, filtered inputs for noise suppression
- Bidirectional data transfer protocol
- 100kHz (1.7V) and 400kHz (2.7V and 5.0V) compatibility
- 16-byte page write modes
- Partial page writes are allowed
- Self-timed write cycle (5ms max)
- High-reliability
  - Endurance: 1 million write cycles
  - Data retention: 100 years
- 8-lead JEDEC SOIC, 8-lead Ultra Thin Mini-MAP (MLP 2x3), 8-lead TSSOP, and 8-ball dBGA2 packages
- Die sales: wafer form, tape and reel, and bumped wafers

## Description

The Atmel® AT34C02C provides 2048 bits of serial electrically-erasable and programmable read only memory (EEPROM) organized as 256 words of eight bits each. The first-half of the device incorporates a permanent and a reversible software write protection feature while hardware write protection for the entire array is available via an external pin. Once the permanent software write protection is enabled, by sending a special command to the device, it cannot be reversed. However, the reversible software write protection is enabled and can be reversed by sending a special command. The hardware write protection is controlled with the WP pin and can be used to protect the entire array, whether or not the software write protection has been enabled. This allows the user to protect none, first-half, or all of the array depending on the application. The device is optimized for use in many industrial and commercial applications where low-power and low-voltage operations are essential. The AT34C02C is available in space saving 8-lead JEDEC SOIC, 8-lead Ultra Thin Mini-MAP (MLP 2x3), 8-lead TSSOP, and 8-ball dBGA2 packages and is accessed via a Two-wire serial interface. It is available in 1.7V (1.7V to 5.5V).
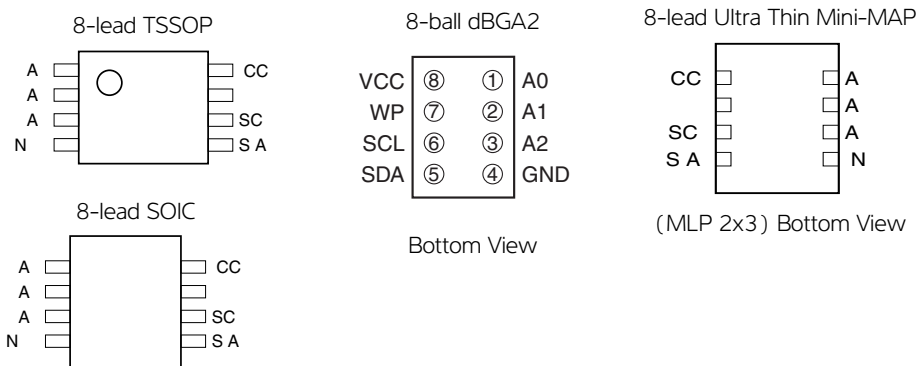
Two-wire Serial Electrically-erasable and Programmable Read Only Memory with Permanent and Reversible Software Write Protect

2K (256 x 8)

Atmel AT34C02C

Not Recommended for New Design

Replaced by AT34C02D



8-lead TSSOP



8-ball dBGA2

Bottom View

8-lead Ultra Thin Mini-MAP

(MLP 2x3) Bottom View

8-lead SOIC

Table 0-1.  Pin configurations

| Pin Name | Function |
|----------|----------|
| A0 – A2 | Address inputs |
| SDA | Serial data |
| SCL | Serial clock input |
| WP | Write protect |

# 1. Absolute maximum ratings*

Operating temperature . . . . . . . . . . . . . . –55°C to +125°C

Storage temperature . . . . . . . . . . . . . . . . –65°C to +150°C

Voltage on any pin
with respect to ground . . . . . . . . . . . . . . . . . – 1.0V to +7.0V

Maximum operating voltage . . . . . . . . . . . . . . . . . . . . 6.25V

DC output current. . . . . . . . . . . . . . . . . . . . . . . . . . . . 5.0mA

*NOTICE:  Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Figure 1-1.  Block diagram
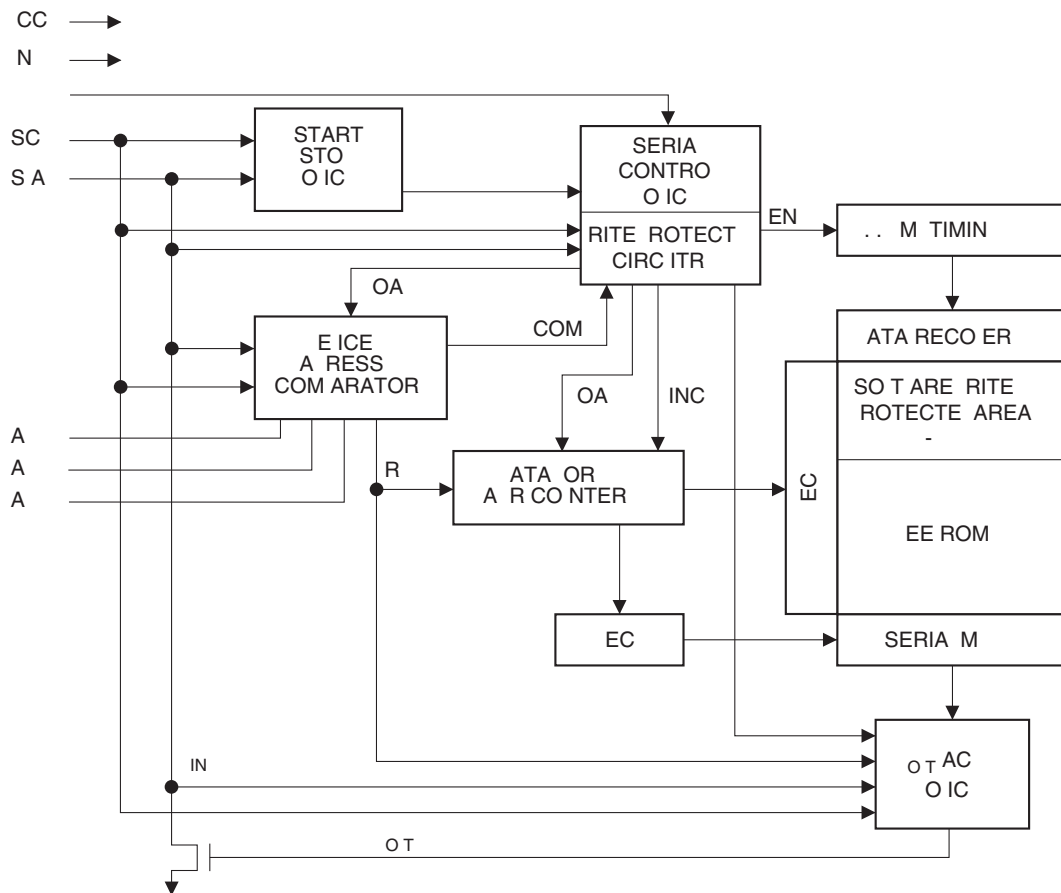
## 2. Pin description

**SERIAL CLOCK (SCL):** The SCL input is used to positive edge clock data into each EEPROM device and negative edge clock data out of each device.

**SERIAL DATA (SDA):** The SDA pin is bidirectional for serial data transfer. This pin is open-drain driven and may be wire-ORed with any number of other open-drain or open collector devices.

**DEVICE/PAGE ADDRESSES (A2, A1, A0):** The A2, A1, and A0 pins are device address inputs that are hardwired (directly to GND or to Vcc) for compatibility with other Atmel AT24Cxx devices. When the pins are hardwired, as many as eight 2K devices may be addressed on a single bus system. (Device addressing is discussed in detail under "Device Addressing," page 9.) A device is selected when a corresponding hardware and software match is true. If these pins are left floating, the A2, A1, and A0 pins will be internally pulled down to GND. However, due to capacitive coupling that may appear during customer applications, Atmel recommends always connecting the address pins to a known state. When using a pull-up resistor, Atmel recommends using 10kΩ or less.

**WRITE PROTECT (WP):** The write protect input, when connected to GND, allows normal write operations. When WP is connected directly to Vcc, all write operations to the memory are inhibited. If the pin is left floating, the WP pin will be internally pulled down to GND. However, due to capacitive coupling that may appear during customer applications, Atmel recommends always connecting the WP pins to a known state. When using a pull-up resistor, Atmel recommends using 10kΩ or less.

Table 2-1.     Atmel AT34C02C write protection modes

| WP pin status | Permanent write protect register | Reversible write protect register | Part of the array write protected |
|---|---|---|---|
| $V_{CC}$ | – | – | Full array (2K) |
| GND or floating | Not programmed | Not programmed | Normal read/write |
| GND or floating | Programmed | – | First-half of array (1K: 00H - 7FH) |
| GND or floating | – | Programmed | First-half of array (1K: 00H - 7FH) |

Table 2-2.     Pin capacitance[1]
Applicable over recommended operating range from $T_A$ = 25□C, f = 100 kHz, $V_{CC}$ = +1.7V

| Symbol | Test condition | Max | Units | Conditions |
|---|---|---|---|---|
| $C_{I/O}$ | Input/output capacitance (SDA) | 8 | pF | $V_{I/O}$ = 0V |
| $C_{IN}$ | Input capacitance ($A_0$, $A_1$, $A_2$, SCL) | 6 | pF | $V_{IN}$ = 0V |

Note:     1. This parameter is characterized and is not 100% tested

Table 2-3.    DC characteristics

Applicable over recommended operating range from: $T_{AI}$ = −40°C to +85°C, $V_{CC}$ = +1.7V to +5.5V, (unless otherwise noted)

| Symbol | Parameter | Test Condition | Min | Typ | Max | Units |
|---|---|---|---|---|---|---|
| $V_{CC}$ | Supply voltage | | 1.7 | | 5.5 | V |
| $I_{CC}$ | Supply current $V_{CC}$ = 5.0V | READ at 100kHz | | 0.4 | 1.0 | mA |
| $I_{CC}$ | Supply current $V_{CC}$ = 5.0V | WRITE at 100kHz | | 2.0 | 3.0 | mA |
| $I_{SB1}$ | Standby current $V_{CC}$ = 1.7V | $V_{IN}$ = $V_{CC}$ or $V_{SS}$ | | 0.6 | 3.0 | μA |
| $I_{SB2}$ | Standby current $V_{CC}$ = 3.6V | $V_{IN}$ = $V_{CC}$ or $V_{SS}$ | | 1.6 | 4.0 | μA |
| $I_{SB3}$ | Standby current $V_{CC}$ = 5.5V | $V_{IN}$ = $V_{CC}$ or $V_{SS}$ | | 8.0 | 18.0 | μA |
| $I_{LI}$ | Input leakage current | $V_{IN}$ = $V_{CC}$ or $V_{SS}$ | | 0.10 | 3.0 | μA |
| $I_{LO}$ | Output leakage current | $V_{OUT}$ = $V_{CC}$ or $V_{SS}$ | | 0.05 | 3.0 | μA |
| $V_{IL}$ | Input low level[1] | | −0.6 | | $V_{CC}$ x 0.3 | V |
| $V_{IH}$ | Input high level[1] | | $V_{CC}$ x 0.7 | | $V_{CC}$ + 0.5 | V |
| $V_{OL2}$ | Output low level $V_{CC}$ = 3.0V | $I_{OL}$ = 2.1mA | | | 0.4 | V |
| $V_{OL1}$ | Output low level $V_{CC}$ = 1.7V | $I_{OL}$ = 0.15mA | | | 0.2 | V |

Note:    1.   $V_{IL}$ min and $V_{IH}$ max are reference only and are not tested

Table 2-4.    AC characteristics

Applicable over recommended operating range from $T_{AI}$ = −40□C to +85□C, $V_{CC}$ = +1.7V to +5.5V, $C_L$ = 1 TTL Gate and 100pF (unless otherwise noted)

| Symbol | Parameter | 1.7V | | 2.7V, 5.0V | | Units |
|---|---|---|---|---|---|---|
| | | Min | Max | Min | Max | |
| $f_{SCL}$ | Clock frequency, SCL | | 100 | | 400 | kHz |
| $t_{LOW}$ | Clock pulse width low | 4.7 | | 1.2 | | μs |
| $t_{HIGH}$ | Clock pulse width high | 4.0 | | 0.6 | | μs |
| $t_I$ | Noise suppression time[1] | | 100 | | 50 | ns |
| $t_{AA}$ | Clock low to data out valid | 0.1 | 4.5 | 0.1 | 0.9 | μs |
| $t_{BUF}$ | Time the bus must be free before a new transmission can start[1] | 4.7 | | 1.2 | | μs |
| $t_{HD.STA}$ | Start hold time | 4.0 | | 0.6 | | μs |
| $t_{SU.STA}$ | Start set-up time | 4.7 | | 0.6 | | μs |
| $t_{HD.DAT}$ | Data in hold time | 0 | | 0 | | μs |
| $t_{SU.DAT}$ | Data In set-up time | 200 | | 100 | | ns |
| $t_R$ | Inputs rise time[1] | | 1.0 | | 0.3 | μs |
| $t_F$ | Inputs fall time[1] | | 300 | | 300 | ns |
| $t_{SU.STO}$ | Stop set-up time | 4.7 | | 0.6 | | μs |
| $t_{DH}$ | Data out hold time | 100 | | 50 | | ns |
| $t_{WR}$ | Write cycle time | | 5 | | 5 | ms |
| Endurance[1] | 25□C, page mode | 1M | | 1M | | Write cycles |

Note:    1.   This parameter is characterized and is not 100% tested.

## 3.    Memory organization

**Atmel AT34C02C, 2K Serial EEPROM:** The 2K is internally organized with 16 pages of 16 bytes each. Random word addressing requires a 8-bit data word address.

## 4.    Device operation

**CLOCK and DATA TRANSITIONS:** The SDA pin is normally pulled high with an external device. Data on the SDA pin may change only during SCL low time periods (see Figure 4-3 on page 6). Data changes during SCL high periods will indicate a start or stop condition as defined below.

**START CONDITION:** A high-to-low transition of SDA with SCL high is a start condition which must precede any other command (see Figure 4-4 on page 6).

**STOP CONDITION:** A low-to-high transition of SDA with SCL high is a stop condition. After a read sequence, the stop command will place the EEPROM in a standby power mode (see Figure 4-4 on page 6).

**ACKNOWLEDGE:** All addresses and data words are serially transmitted to and from the EEPROM in 8-bit words. The EEPROM sends a zero to acknowledge that it has received each word. This happens during the ninth clock cycle.

**STANDBY MODE:** The Atmel AT34C02C features a low-power standby mode which is enabled:

- Upon power-up or
- After the receipt of the STOP bit and the completion of any internal operations

**MEMORY RESET:** After an interruption in protocol, power loss or system reset, any Two-wire part can be reset by following these steps:

- Clock up to nine cycles
- Look for SDA high in each cycle while SCL is high and then
- Create a start condition.

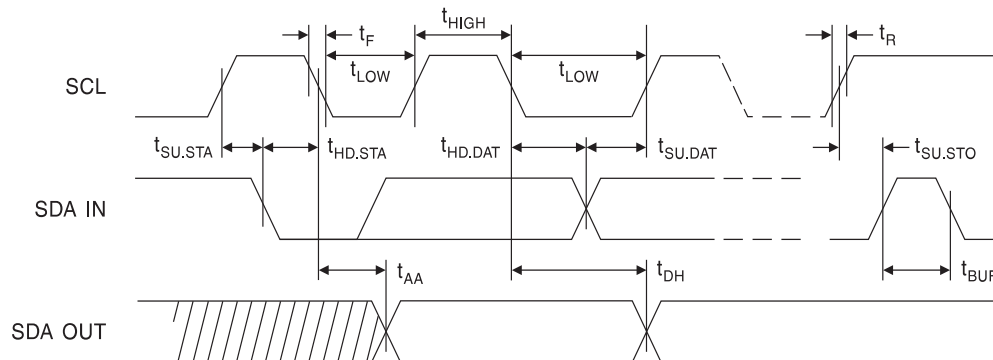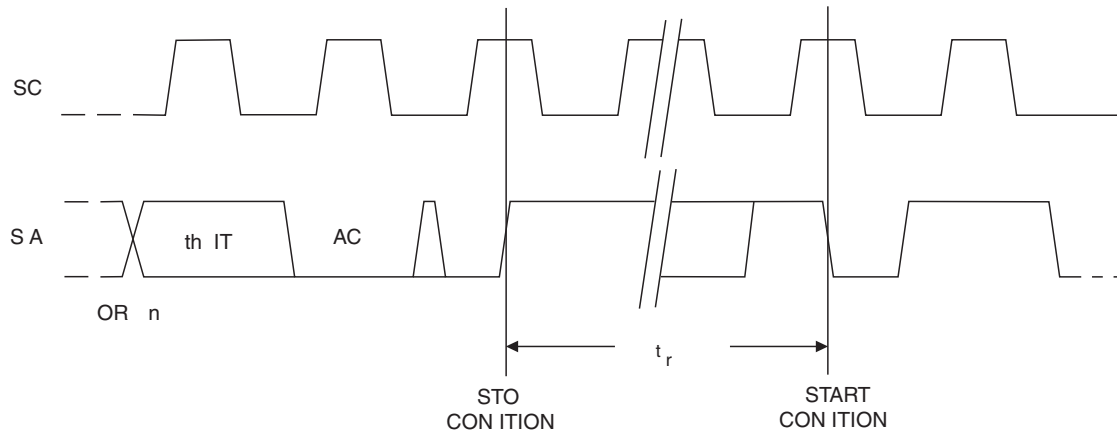Figure 4-1.    Bus timing SCL: Serial clock SDA: Serial data I/O

Figure 4-2.    Write cycle timing SCL: Serial clock SDA: Serial data I/O



SC

S A       th  IT        AC

OR   n

$t_r$

STO
CON ITION

START
CON ITION

Note:    1.    The write cycle time $t_{WR}$ is the time from a valid stop condition of a write sequence to the end of the internal clear/write cycle.
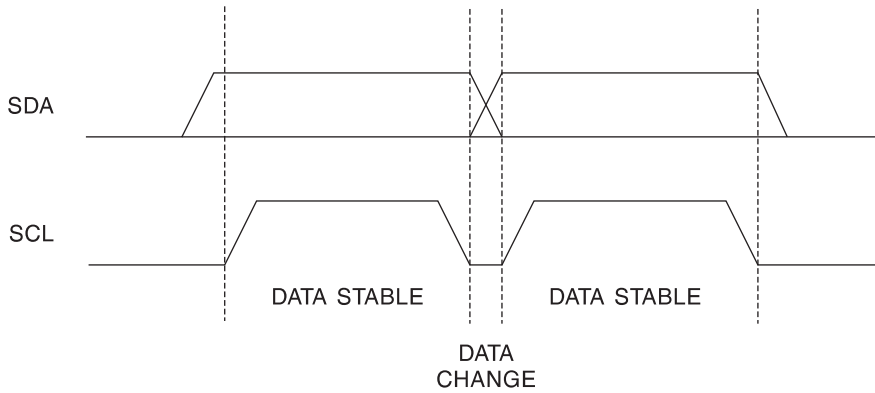
Figure 4-3.    Data validity



SDA

SCL

DATA  STABLE          DATA  STABLE

DATA
CHANGE

Figure 4-4.    Start and stop condition



SDA
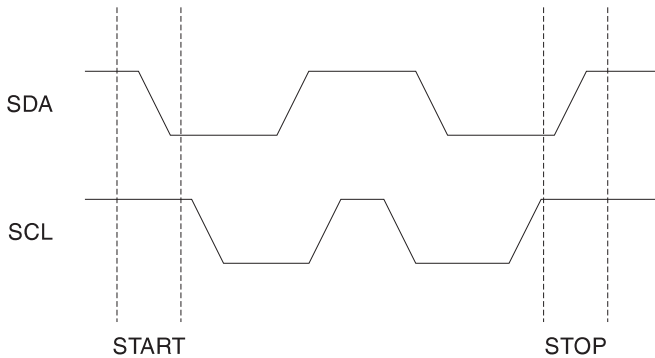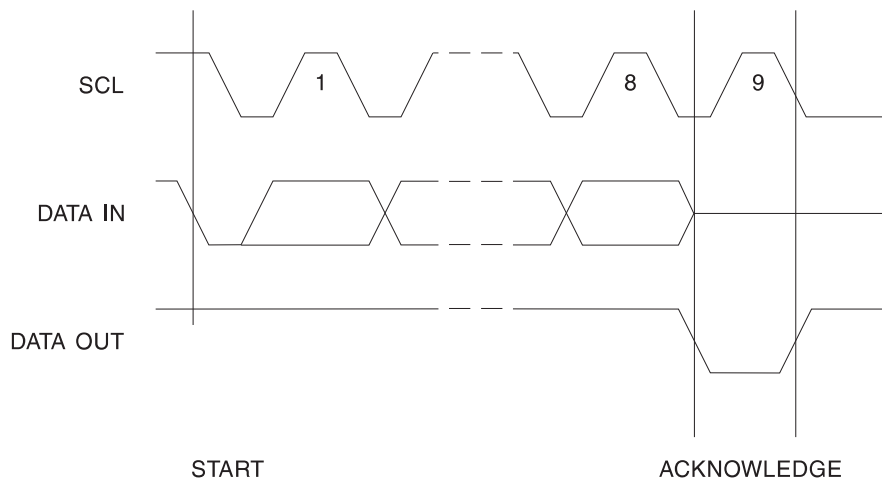
SCL

START                    STOP

Figure 4-5.     Output acknowledge



## 5.     Device addressing

The 2K EEPROM device requires an 8-bit device address word following a start condition to enable the chip for a read or write operation (see Figure 8-1 on page 12).

The device address word consists of a mandatory one-zero sequence for the first four most-significant bits (1010) for normal read and write operations and 0110 for writing to the write protect register.

The next three bits are the A2, A1, and A0 device address bits for the Atmel AT34C02C EEPROM. These three bits must compare to their corresponding hard-wired input pins.

The eighth bit of the device address is the read/write operation select bit. A read operation is initiated if this bit is high and a write operation is initiated if this bit is low.

Upon a compare of the device address, the EEPROM will output a zero. If a compare is not made, the chip will return to a standby state. The device will not acknowledge if the write protect register has been programmed and the control code is 0110.

## 6.     Write operations

**BYTE WRITE:** A write operation requires an 8-bit data word address following the device address word and acknowledgment. Upon receipt of this address, the EEPROM will again respond with a zero and then clock in the first 8-bit data word. Following receipt of the 8-bit data word, the EEPROM will output a zero and the addressing device, such as a microcontroller, must terminate the write sequence with a stop condition. At this time the EEPROM enters an internally-timed write cycle, $t_{WR}$, to the nonvolatile memory. All inputs are disabled during this write cycle and the EEPROM will not respond until the write is complete (see Figure 8-2 on page 12).

The device will acknowledge a write command, but not write the data, if the software or hardware write protection has been enabled. The write cycle time must be observed even when the write protection is enabled.

**PAGE WRITE:** The 2K device is capable of 16-byte page write.

A page write is initiated the same as a byte write, but the microcontroller does not send a stop condition after the first data word is clocked in. Instead, after the EEPROM acknowledges receipt of the first data word, the microcontroller can transmit up to fifteen more data words. The EEPROM will respond with a zero after each data word received. The microcontroller must terminate the page write sequence with a stop condition (see Figure 8-3 on page 12).

The data word address lower four bits are internally incremented following the receipt of each data word. The higher data word address bits are not incremented, retaining the memory page row location. When the word address, internally generated, reaches the page boundary, the following byte is placed at the beginning of the same page. If more than sixteen data words are transmitted to the EEPROM, the data word address will "roll over" and previous data will be overwritten. The address "roll over" during write is from the last byte of the current page to the first byte of the same page.

The device will acknowledge a write command, but not write the data, if the software or hardware write protection has been enabled. The write cycle time must be observed even when the write protection is enabled.

**ACKNOWLEDGE POLLING:** Once the internally-timed write cycle has started and the EEPROM inputs are disabled, acknowledge polling can be initiated. This involves sending a start condition followed by the device address word. The read/write bit is representative of the operation desired. Only if the internal write cycle has completed will the EEPROM respond with a zero allowing the read or write sequence to continue.

## 7. Write protection

The software write protection, once enabled, write protects only the first-half of the array (00H - 7FH) while the hardware write protection, via the WP pin, is used to protect the entire array.

**PERMANENT SOFTWARE WRITE PROTECTION:** The software write protection is enabled by sending a command, similar to a normal write command, to the device which programs the permanent write protect register. This must be done with the WP pin low. The write protect register is programmed by sending a write command with the device address of 0110 instead of 1010 with the address and data bit being don't cares (see Figure 7-1 on page 8). Once the software write protection has been enabled, the device will no longer acknowledge the 0110 control byte. The software write protection cannot be reversed even if the device is powered down. The write cycle time must be observed.

**REVERSIBLE SOFTWARE WRITE PROTECTION**: The reversible software write protection is enabled by sending a command, similar to a normal write command, to the device which programs the reversible write protect register. This must be done with the WP pin low. The write protect register is programmed by sending a write command 01100010 with pins $A_2$ and $A_1$ tied to ground or don't connect and pin $A_0$ connected to VHV (see Figure 7-2). The reversible write protection can be reversed by sending a command 01100110 with pin $A_2$ tied to ground or no connect, pin $A_1$ tied to $V_{CC}$ and pin $A_0$ tied to VHV (see Figure 7-3).

**HARDWARE WRITE PROTECTION:** The WP pin can be connected to $V_{CC}$, GND, or left floating. Connecting the WP pin to $V_{CC}$ will write protect the entire array, regardless of whether or not the software write protection has been enabled. The software write protection register cannot be programmed when the WP pin is connected to $V_{CC}$. If the WP pin is connected to GND or left floating, the write protection mode is determined by the status of the software write protect register.

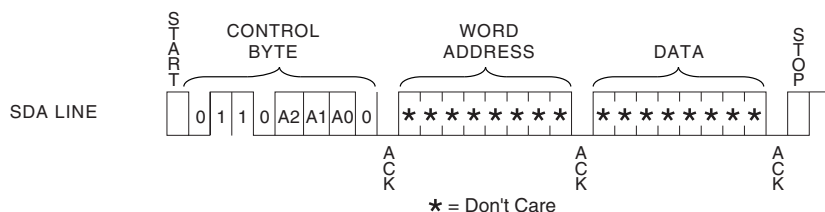Figure 7-1.    Setting permanent write protect register (PSWP)
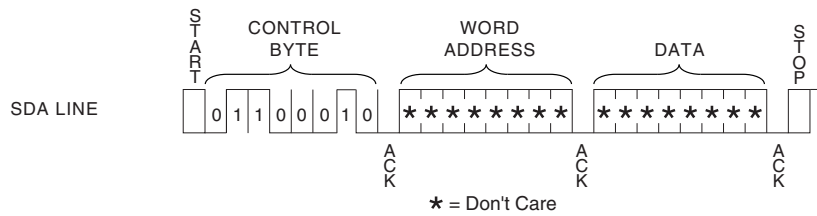
Figure 7-2. Setting reversible write protect register（RSWP）



Figure 7-3. Clearing reversible write protect register（RSWP）
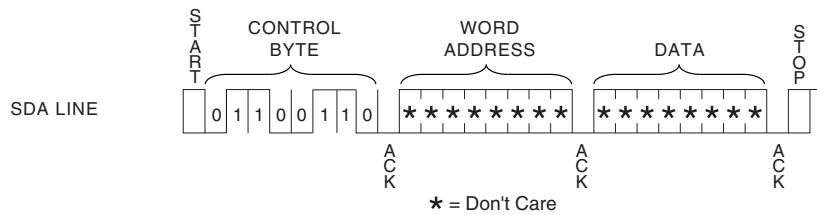


Table 7-1. Write protection

| Command | Pin | | | Preamble | | | | | | | RW |
|---|---|---|---|---|---|---|---|---|---|---|---|
| | A2 | A1 | A0 | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 |
| Set PSWP | A2 | A1 | A0 | 0 | 1 | 1 | 0 | A2 | A1 | A0 | 0 |
| Set RSWP | 0 | 0 | VHV | 0 | 1 | 1 | 0 | 0 | 0 | 1 | 0 |
| Clear RSWP | 0 | 1 | VHV | 0 | 1 | 1 | 0 | 0 | 1 | 1 | 0 |

Table 7-2. VHV

| | Min | Max | Units |
|---|---|---|---|
| VHV | 7 | 10 | V |

Note: VHV - $V_{CC}$ > 4.8V

Table 7-3. WP connected to GND or floating

| WP connected to GND or floating | | | | | |
|---|---|---|---|---|---|
| Command | R/W bit | Permanent write protect register PSWP | Reversible write protect register RSWP | Acknowledgment from device | Action from device |
| 1010 | R | X | X | ACK | |
| 1010 | W | Programmed | X | ACK | Can write to second Half (80H – FFH) only |
| 1010 | W | X | Programmed | ACK | Can write to second Half (80H – FFH) only |
| 1010 | W | Not programmed | Not programmed | ACK | Can write to full array |
| | | | | | |
| Read PSWP | R | Programmed | X | No ACK | STOP - Indicates permanent write protect register is programmed |
| Read PSWP | R | Not programmed | X | ACK | Read out data don't care. Indicates PSWP register is not programmed |
| Set PSWP | W | Programmed | X | No ACK | STOP - Indicates permanent write protect register is programmed |
| Set PSWP | W | Not programmed | X | ACK | Program permanent write protect register (irreversible) |
| | | | | | |
| Read RSWP | R | X | Programmed | No ACK | STOP - Indicates reversible write protect register is programmed |
| Read RSWP | R | X | Not programmed | ACK | Read out data don't care. Indicates RSWP register is not programmed |
| Set RSWP | W | X | Programmed | No ACK | STOP - Indicates reversible write protect register is programmed |
| Set RSWP | W | X | Not programmed | ACK | Program reversible write protect register (reversible) |
| Clear RSWP | W | Programmed | X | No ACK | STOP - Indicates permanent write protect register is programmed |
| Clear RSWP | W | Not programmed | X | ACK | Clear (unprogram) reversible write protect register (reversible) |

Table 7-4.        WP connected to Vcc

| WP connected to Vcc | | | | | |
| --- | --- | --- | --- | --- | --- |
| Command | R/W bit | Permanent write protect register PSWP | Reversible write protect register RSWP | Acknowledgment from device | Action from device |
| 1010 | R | X | X | ACK | Read array |
| 1010 | W | X | X | ACK | Device write protect |
| | | | | | |
| Read PSWP | R | Programmed | X | No ACK | STOP – Indicates permanent write protect register is programmed |
| Read PSWP | R | Not programmed | X | ACK | Read out data don't care. Indicates PSWP register is not programmed |
| Set PSWP | W | Programmed | X | No ACK | STOP – Indicates permanent write protect register is programmed |
| Set PSWP | W | Not programmed | X | ACK | Cannot program write protect registers |
| | | | | | |
| Read RSWP | R | X | Programmed | No ACK | STOP – Indicates reversible write protect register is programmed |
| Read RSWP | R | X | Not programmed | ACK | Read out data don't care. Indicates RSWP register is not programmed |
| Set RSWP | W | X | Programmed | No ACK | STOP – Indicates reversible write protect register is programmed |
| Set RSWP | W | X | Not programmed | ACK | Cannot program write protect registers |
| Clear RSWP | W | Programmed | X | No ACK | STOP – Indicates permanent write protect register is programmed |
| Clear RSWP | W | Not programmed | X | ACK | Cannot write to write protect registers |

## 8.    Read operations

Read operations are initiated the same way as write operations with the exception that the read/write select bit in the device address word is set to one. There are three read operations:

- Current address read
- Random address read
- Sequential read.

**CURRENT ADDRESS READ:** The internal data word address counter maintains the last address accessed during the last read or write operation, incremented by one. This address stays valid between operations as long as the chip power is maintained. The address "roll over" during read is from the last byte of the last memory page to the first byte of the first page.

Once the device address with the read/write select bit set to one is clocked in and acknowledged by the EEPROM, the current address data word is serially clocked out. To end the command, the microcontroller does not respond with an input zero but does generate a following stop condition (see Figure 8-4 on page 13).

**RANDOM READ:** A random read requires a "dummy" byte write sequence to load in the data word address. Once the device address word and data word address are clocked in and acknowledged by the EEPROM, the microcontroller must generate another start condition. The microcontroller now initiates a current address read by sending a device address with the read/write select bit high. The EEPROM acknowledges the device address and serially clocks out the data word. To end the command, the microcontroller does not respond with a zero but does generate a following stop condition (see Figure 8-5 on page 13).

**SEQUENTIAL READ:** Sequential reads are initiated by either a current address read or a random address read. After the microcontroller receives a data word, it responds with an acknowledge. As long as the EEPROM receives an acknowledge, it will continue to increment the data word address and serially clock out sequential data words. When the memory address limit is reached, the data word address will "roll over" and the sequential read will continue. The sequential read operation is terminated when the microcontroller does not respond with a zero but does generate a following stop condition (see ).

**PERMANENT WRITE PROTECT REGISTER (PSWP) STATUS: To find out if the register has been programmed, the same procedure is used as to program the register except that the R/W bit is set to one. If the device sends an acknowledge, then the permanent write protect register has not been programmed. Otherwise, it has been programmed and the device is permanently write protected at the first half of the array.**

Table 8-1.     PSWP status

| Command | Pin | | | Preamble | | | | | | | RW |
|---|---|---|---|---|---|---|---|---|---|---|---|
| | A2 | A1 | A0 | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 |
| Read PSWP | A2 | A1 | A0 | 0 | 1 | 1 | 0 | A2 | A1 | A0 | 1 |

**REVERSIBLE WRITE PROTECT REGISTER(RSWP) STATUS: To find out if the register has been programmed, the same procedure is used as to program the register except that the R/W bit is set to one. If the sends an device acknowledge, then the reversible write protect register has not been programmed. Otherwise, it has been programmed and the device is write protected (reversible) at the first half of the array.**

Figure 8-1.     Device address

| 1 | 0 | 1 | 0 | $A_2$ | $A_1$ | $A_0$ | R/W |
|---|---|---|---|---|---|---|---|

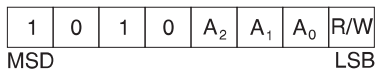MSD                                                  LSB
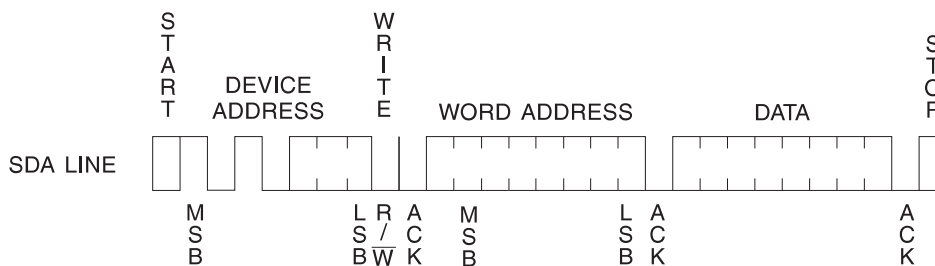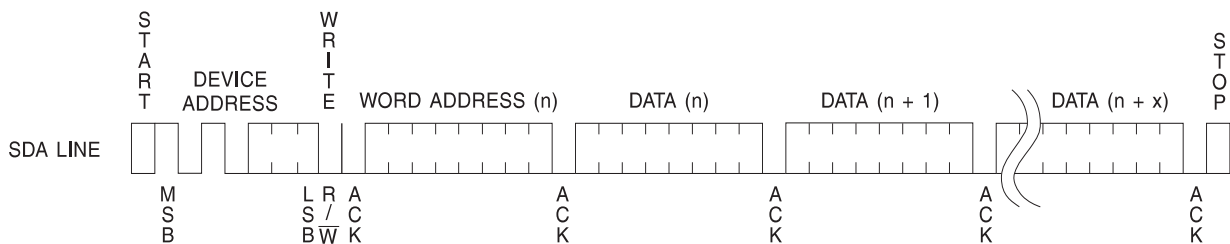
Figure 8-2.     Byte write



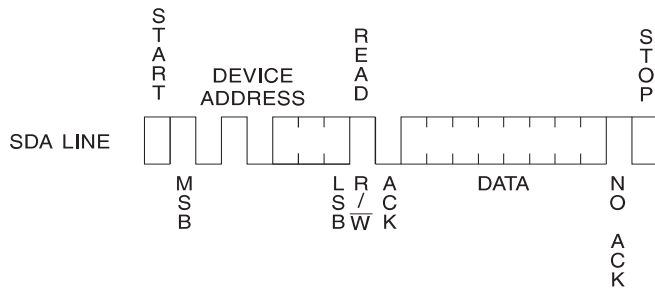Figure 8-3.     Page write

Figure 8-4. Current address read
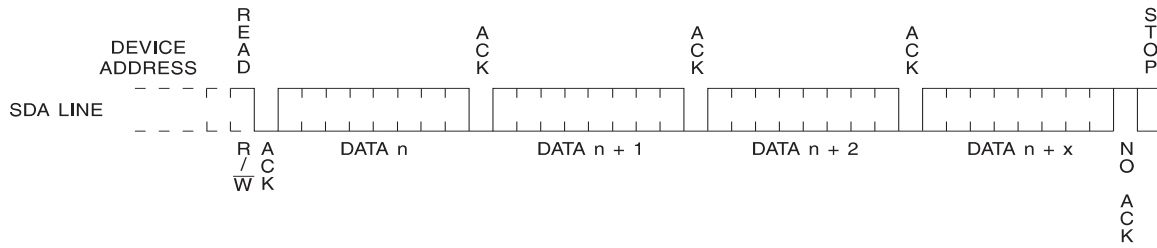


Figure 8-5. Random read
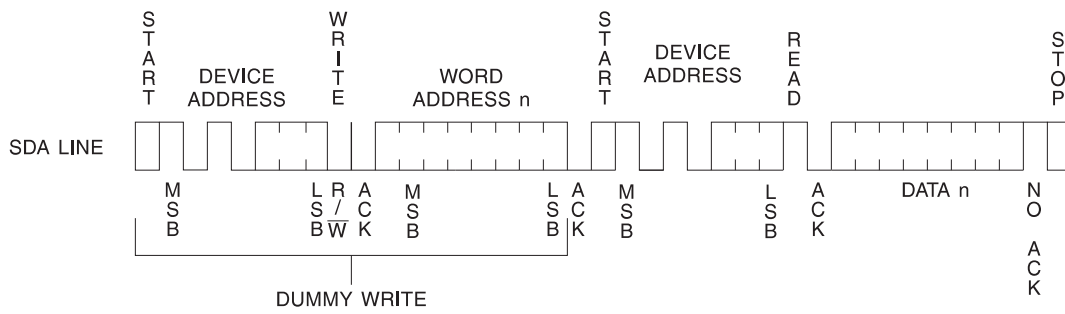


Figure 8-6. Sequential read

## 9.   Atmel AT34C02C ordering information

| Atmel ordering code | Package | Operation range |
|---|---|---|
| AT34C02CN-SH-B[1] (NiPdAu lead finish) | 8S1 | Lead-free/Halogen-free/ Industrial temperature (−40°C to 85°C) |
| AT34C02CN-SH-T[2] (NiPdAu lead finish) | 8S1 | |
| AT34C02C-TH-B[1] (NiPdAu lead finish) | 8A2 | |
| AT34C02C-TH-T[2] (NiPdAu lead finish) | 8A2 | |
| AT34C02CY6-YH-T[2] (NiPdAu lead finish) | 8Y6 | |
| AT34C02CU3-UU-T[2] | 8U3-1 | |

Notes:   1.   "-B" denotes bulk

2.   "-T" denotes tape and reel. SOIC = 4K per reel; TSSOP, Ultra Thin Mini MAP and dBGA2 = 5K per reel.

| Package type | |
|---|---|
| 8S1 | 8-lead, 0.150″ Wide, Plastic Gull Wing Small Outline package (JEDEC SOIC) |
| 8A2 | 8-lead, 0.170″ Wide, Thin Shrink Small Outline package (TSSOP) |
| 8Y6 | 8-lead, 2.00mm x 3.00mm Body, 0.50mm Pitch, Ultra Thin Mini-MAP, Dual No Lead package (DFN), (MLP 2x3mm) |
| 8U3-1 | 8-ball, die Ball Grid Array package (dBGA2) |
| Options | |
| −1.7 | Low voltage (1.7V to 5.5V) |

## 10. Part markings

### 8 lead TSSOP
2 Rows/Top & Bottom
4/5 Top-7/7 Bottom Characters

HYWW
34C 1
— Top

LOA
AAAAAAA
— Bottom

### 8 lead SOIC
3 Rows of 8 Characters

ATMLHYWW
34C1
AAAAAAAA

### 8-ball VFBGA - 1.5x2.0mm
2 Rows of 4 Characters

34CU
YMXX

∠ PIN 1

### 8 lead UDFN - 2.0x3.0mm
3 Rows of 3 Characters

34C
H1@
YXX

∠ PIN 1

Catalog Number: AT34C02C       Catalog Truncation: 34C

| Date Codes | | | Voltages |
|---|---|---|---|
| Y = Year | M = Month | WW = Work Week of Assembly | 1: 1.7v min |
| 0: 2010  4: 2014<br>1: 2011  5: 2015<br>2: 2012  6: 2016<br>3: 2013  7: 2017 | A: January<br>B: February<br>" " "<br>L: December | 02: Week 2<br>04: Week 4<br>" " "<br>52: Week 52 | |

| Trace Code | Grade/Lead Finish Material |
|---|---|
| XX = Trace Code (ATMEL Lot Numbers to Correspond to Code)<br>(e.g. XX:     AA, AB...YZ, ZZ) | U:  Industrial/Matt Tin<br>H:  Industrial/NiPdAu |

| Lot Number | |
|---|---|
| AAAAAAA = ATMEL Wafer Lot Number | |

| Location of Assembly | ATMEL Truncation |
|---|---|
| @ = Location of Assembly | AT:  ATMEL<br>ATM:  ATMEL<br>ATML:  ATMEL |

3/17/11

| | TITLE | DRAWING NO. | REV. |
|---|---|---|---|
| Package Mark Contact:<br>DL-CSO-Assy_eng@atmel.com | 34C02CSM,  AT34C02C Standard Marking Information<br>for Package Offering | 34C02CSM | A |

## 11.    Packaging Information

### 8S1 – JEDEC SOIC



**TOP VIEW**

**END VIEW**

**SIDE VIEW**

Notes:  This drawing is for general information only.
Refer to JEDEC Drawing MS-012, Variation AA
for proper dimensions, tolerances, datums, etc.

**COMMON DIMENSIONS**
(Unit of Measure = mm)

| SYMBOL | MIN | NOM | MAX | NOTE |
|--------|------|------|------|------|
| A | 1.35 | – | 1.75 | |
| A1 | 0.10 | – | 0.25 | |
| b | 0.31 | – | 0.51 | |
| C | 0.17 | – | 0.25 | |
| D | 4.80 | – | 5.05 | |
| E1 | 3.81 | – | 3.99 | |
| E | 5.79 | – | 6.20 | |
| e | 1.27 BSC | | | |
| L | 0.40 | – | 1.27 | |
| Ø | 0° | – | 8° | |

5/19/10

| | TITLE | GPC | DRAWING NO. | REV. |
|---|---|---|---|---|
| **Package Drawing Contact:** packagedrawings@atmel.com | **8S1**, 8-lead (0.150″ Wide Body), Plastic Gull Wing Small Outline (JEDEC SOIC) | SWB | 8S1 | F |

## 8A2 – TSSOP



3  2  1

Pin 1 indicator
this corner

E1

E

N

Top View

L1

L

End View

b

A

e

A2

D

Side View

COMMON DIMENSIONS
(Unit of Measure = mm)

| SYMBOL | MIN | NOM | MAX | NOTE |
|--------|-----|-----|-----|------|
| D | 2.90 | 3.00 | 3.10 | 2, 5 |
| E | 6.40 BSC | | | |
| E1 | 4.30 | 4.40 | 4.50 | 3, 5 |
| A | – | – | 1.20 | |
| A2 | 0.80 | 1.00 | 1.05 | |
| b | 0.19 | – | 0.30 | 4 |
| e | 0.65 BSC | | | |
| L | 0.45 | 0.60 | 0.75 | |
| L1 | 1.00 REF | | | |
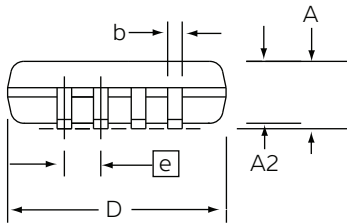
Notes: 1. This drawing is for general information only. Refer to JEDEC Drawing MO-153, Variation AA, for proper dimensions, tolerances, datums, etc.
2. Dimension D does not include mold Flash, protrusions or gate burrs. Mold Flash, protrusions and gate burrs shall not exceed 0.15mm (0.006in) per side.
3. Dimension E1 does not include inter-lead Flash or protrusions. Inter-lead Flash and protrusions shall not exceed 0.25mm (0.010in) per side.
4. Dimension b does not include Dambar protrusion. Allowable Dambar protrusion shall be 0.08mm total in excess of the b dimension at maximum material condition. Dambar cannot be located on the lower radius of the foot. Minimum space between protrusion and adjacent lead is 0.07mm.
5. Dimension D and E1 to be determined at Datum Plane H.

5/19/10

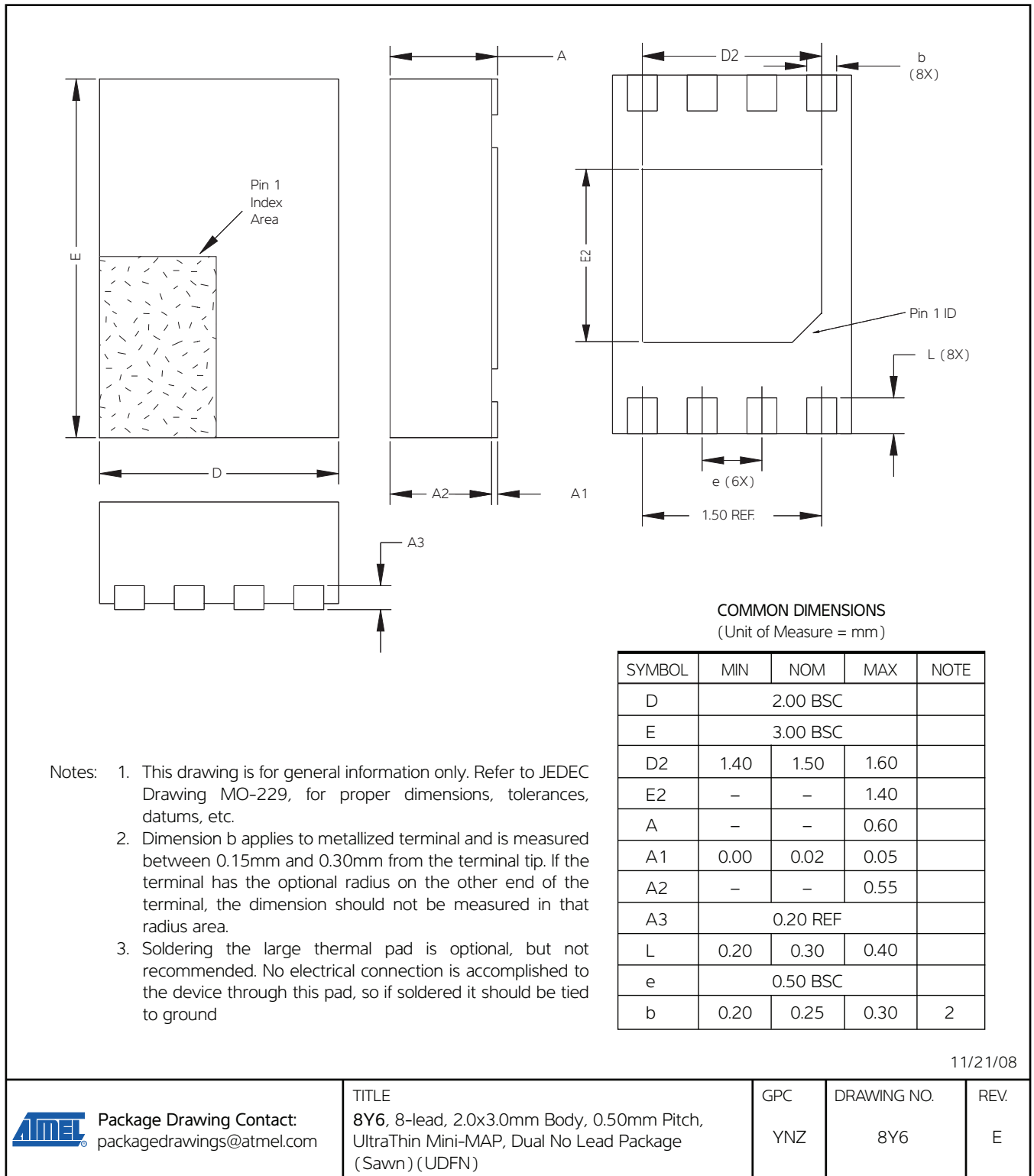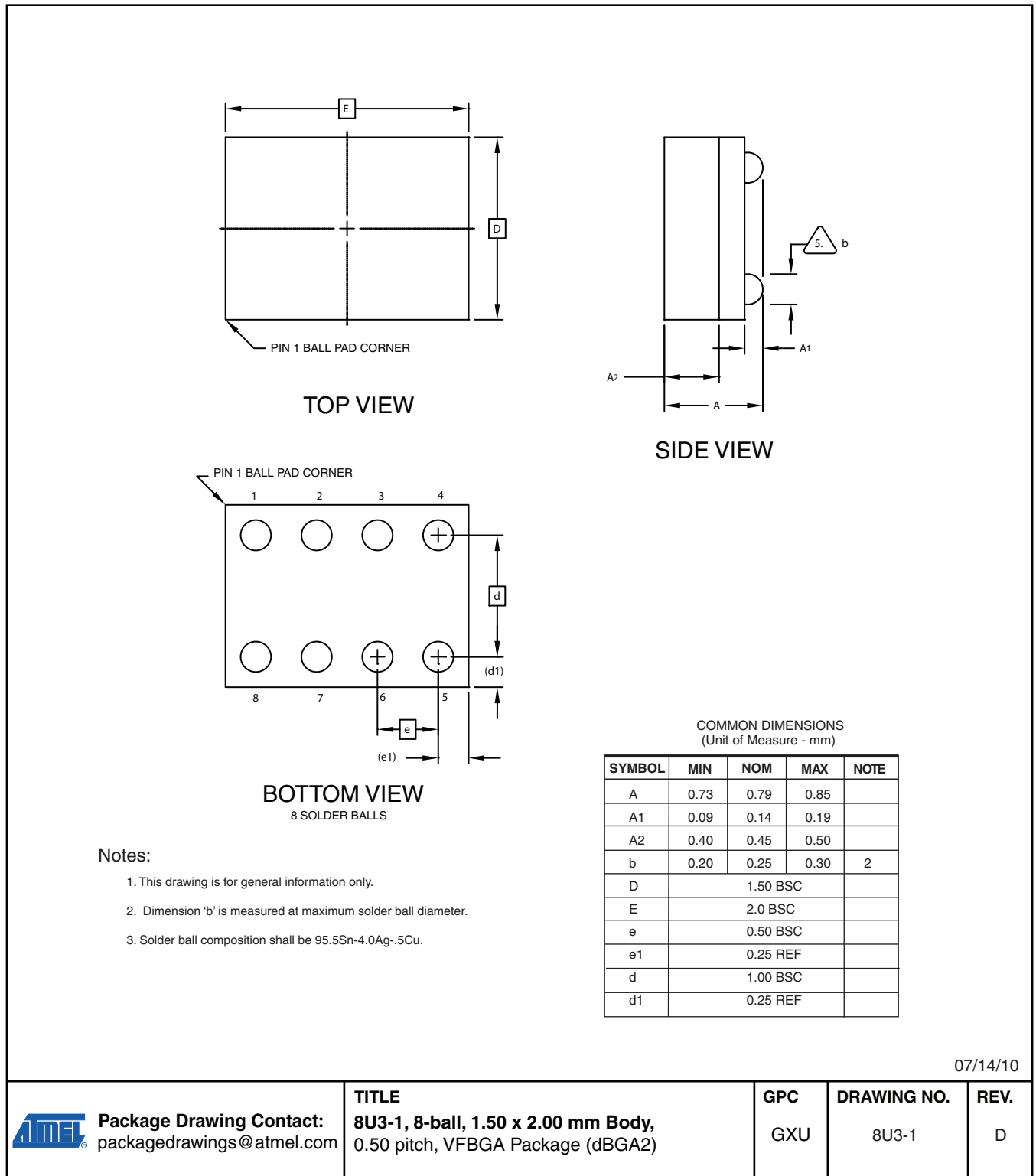| | TITLE | GPC | DRAWING NO. | REV. |
|---|---|---|---|---|
| Package Drawing Contact: packagedrawings@atmel.com | **8A2**, 8-lead 4.4mm Body, Plastic Thin Shrink Small Outline Package (TSSOP) | TNR | 8A2 | E |

## 8Y6 – Mini-MAP



### COMMON DIMENSIONS
(Unit of Measure = mm)

| SYMBOL | MIN | NOM | MAX | NOTE |
|--------|-----|-----|-----|------|
| D | | 2.00 BSC | | |
| E | | 3.00 BSC | | |
| D2 | 1.40 | 1.50 | 1.60 | |
| E2 | – | – | 1.40 | |
| A | – | – | 0.60 | |
| A1 | 0.00 | 0.02 | 0.05 | |
| A2 | – | – | 0.55 | |
| A3 | | 0.20 REF | | |
| L | 0.20 | 0.30 | 0.40 | |
| e | | 0.50 BSC | | |
| b | 0.20 | 0.25 | 0.30 | 2 |

Notes: 1. This drawing is for general information only. Refer to JEDEC Drawing MO-229, for proper dimensions, tolerances, datums, etc.
2. Dimension b applies to metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip. If the terminal has the optional radius on the other end of the terminal, the dimension should not be measured in that radius area.
3. Soldering the large thermal pad is optional, but not recommended. No electrical connection is accomplished to the device through this pad, so if soldered it should be tied to ground

11/21/08

| | TITLE | GPC | DRAWING NO. | REV. |
|--|-------|-----|-------------|------|
| **Package Drawing Contact:** packagedrawings@atmel.com | 8Y6, 8-lead, 2.0x3.0mm Body, 0.50mm Pitch, UltraThin Mini-MAP, Dual No Lead Package (Sawn)(UDFN) | YNZ | 8Y6 | E |

8U3-1 – dBGA2

TOP VIEW

PIN 1 BALL PAD CORNER

E

D

SIDE VIEW

A2

A

A1

b

5.

BOTTOM VIEW

8 SOLDER BALLS

PIN 1 BALL PAD CORNER

| 1 | 2 | 3 | 4 |

| 8 | 7 | 6 | 5 |

d

(d1)

e

(e1)

Notes:

1. This drawing is for general information only.

2. Dimension 'b' is measured at maximum solder ball diameter.

3. Solder ball composition shall be 95.5Sn-4.0Ag-.5Cu.

COMMON DIMENSIONS
(Unit of Measure - mm)

| SYMBOL | MIN | NOM | MAX | NOTE |
|--------|-----|-----|-----|------|
| A | 0.73 | 0.79 | 0.85 | |
| A1 | 0.09 | 0.14 | 0.19 | |
| A2 | 0.40 | 0.45 | 0.50 | |
| b | 0.20 | 0.25 | 0.30 | 2 |
| D | | 1.50 BSC | | |
| E | | 2.0 BSC | | |
| e | | 0.50 BSC | | |
| e1 | | 0.25 REF | | |
| d | | 1.00 BSC | | |
| d1 | | 0.25 REF | | |

07/14/10

**Package Drawing Contact:**
packagedrawings@atmel.com

| TITLE | GPC | DRAWING NO. | REV. |
|-------|-----|-------------|------|
| **8U3-1, 8-ball, 1.50 x 2.00 mm Body,** 0.50 pitch, VFBGA Package (dBGA2) | GXU | 8U3-1 | D |

## 12. Revision history

| Doc. rev. | Date | Comments |
| --- | --- | --- |
| 5185E | 09/2013 | Not recommended for new design. Replaced by AT34C02D. |
| 5185E | 03/2011 | Replaced part markings to single page part markings<br>Updated template |
| 5185D | 01/2008 | Removed 'preliminary' status |
| 5185C | 08/2007 | Updated to new template<br>Added package marking tables |
| 5185B | 03/2007 | Implemented revision history |

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